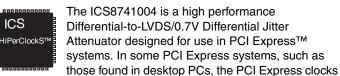
# 

## DIFFERENTIAL-TO-LVDS/0.7V DIFFERENTIAL PCI EXPRESS™ JITTER ATTENUATOR

# ICS8741004

# **General Description**



are generated from a low bandwidth, high phase noise PLL frequency synthesizer. In these systems, a jitter attenuator may be required to attenuate high frequency random and deterministic iitter components from the PLL synthesizer and from the system board. The ICS8741004 has 3 PLL bandwidth modes: 200kHz, 600kHz and 2MHz. The 200kHz mode will provide maximum jitter attenuation, but with higher PLL tracking skew and spread spectrum modulation from the motherboard synthesizer may be attenuated. The 600kHz provides an intermediate bandwidth that can easily track triangular spread profiles, while providing good jitter attenuation. The 2MHz bandwidth provides the best tracking skew and will pass most spread profiles, but the jitter attenuation will not be as good as the lower bandwidth modes. Because some 2.5Gb serdes have x20 multipliers while others have x25 multipliers, the ICS8741004 can be set for 1:1 mode or 5/4 multiplication mode (i.e. 100MHz input/125MHz output) using the F SEL pins.

The ICS8741004 uses IDT's 3<sup>rd</sup> Generation FemtoClock<sup>™</sup> PLL technology to achieve the lowest possible phase noise. The device is packaged in a 24 Lead TSSOP package, making it ideal for use in space constrained applications such as PCI Express add-in cards.

#### PLL Bandwidth

BW\_SEL 0 = PLL Bandwidth: ~200kHz Float = PLL Bandwidth: ~600kHz (default) 1 = PLL Bandwidth: ~2MHz

## **Features**

- Two LVDS and two 0.7V differential output pairs Bank A has two LVDS output pairs and Bank B has two 0.7V differential output pairs
- · One differential clock input pair
- CLK, CLK pair can accept the following differential input levels: LVPECL, LVDS, LVHSTL, SSTL, HCSL
- Output frequency range: 98MHz 160MHz
- Input frequency range: 98MHz 128MHz
- VCO range: 490MHz 640MHz
- Cycle-to-cycle jitter: 35ps (maximum)
- Full 3.3V operating supply
- Three bandwidth modes allow the system designer to make jitter attenuation/tracking skew design trade-offs
- 0°C to 70°C ambient operating temperature
- Available in both standard (RoHS 5) and lead-free (RoHS 6) packages

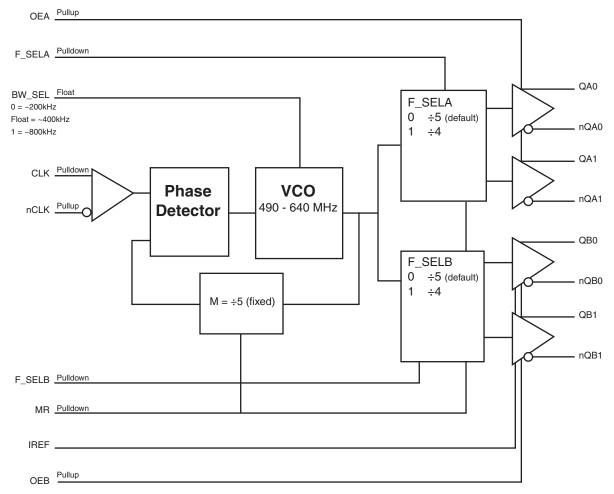
# **Pin Assignment**

nQA1 🗌	1	24	nQB1
QA1 🗆	2	23	QB1
V <sub>DDO</sub>	3	22	
QA0 🗆	4	21	QB0
nQA0 🗖	5	20	nQB0
MR 🗆	6	19	IREF
BW_SEL	7	18	F_SELB
nc 🗖	8	17	OEB
V <sub>DDA</sub>	9	16	🗆 GND
F_SELA	10	15	GND
V <sub>DD</sub>	11	14	nCLK
OEA 🗆	12	13	CLK

## ICS8741004

24-Lead TSSOP 4.4mm x 7.8mm x 0.925mm package body G Package Top View

# **Block Diagram**



# **Table 1. Pin Descriptions**

Number	Name	T	уре	Description
1, 2	QA1, QA1	Output		Differential output pair. LVDS interface levels.
3, 22	V <sub>DDO</sub>	Power		Output supply pins.
4, 5	QA0, <u>QA0</u>	Output		Differential output pair. LVDS interface levels.
6	MR	Input	Pulldown	Active High Master Reset. When logic HIGH, the internal dividers are reset causing the true outputs $Q[Ax:Bx]$ to go LOW and the inverted outputs $\overline{Q[Ax:Bx]}$ to go HIGH. When logic LOW, the internal dividers and the outputs are enabled. LVCMOS/LVTTL interface levels.
7	BW_SEL	Input	Pullup/ Pulldown	PLL Bandwidth input. LVCMOS/LVTTL interface levels. See Table 3B.
8	nc	Unused		No connect.
9	V <sub>DDA</sub>	Power		Analog supply pin.
10	F_SELA	Input	Pulldown	Frequency select pins for QAx/QAx outputs. LVCMOS/LVTTL interface levels. See Table 3C.
11	V <sub>DD</sub>	Power		Core supply pin.
12	OEA	Input	Pullup	Output enable for QAx pins. When HIGH, QAx/QAx outputs are enabled. When LOW, the QAx/QAx outputs are in a high impedance state. LVCMOS/LVTTL interface levels. See Table 3A.
13	CLK	Input	Pulldown	Non-inverting differential clock input.
14	CLK	Input	Pullup	Inverting differential clock input.
15, 16	GND	Power		Power supply ground.
17	OEB	Input	Pullup	Output enable for QBx pins. When HIGH, QBx/QBx outputs are enabled. When LOW, the QBx/QBx outputs are in a high impedance state. LVCMOS/LVTTL interface levels. See Table 3A.
18	F_SELB	Input	Pulldown	Frequency select pins for QBx/QBx outputs. LVCMOS/LVTTL interface levels. See Table 3C.
19	IREF	Input		A fixed precision resistor (RREF = $475\Omega$ ) from this pin to ground provides a reference current used for differential current-mode QB0/nQB0 clock outputs.
20, 21	<u>QB0</u> , QB0	Output		Differential output pair. HCSL interface levels.
23, 24	QB1, QB1	Output		Differential output pair. HCSL interface levels.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

# **Table 2. Pin Characteristics**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C <sub>IN</sub>	Input Capacitance			4		pF
R <sub>PULLUP</sub>	Input Pullup Resistor			51		kΩ
R <sub>PULLDOWN</sub>	Input Pulldown Resistor			51		kΩ

## **Function Tables**

## Table 3A. Output Enable Function Table

Inputs		Outputs		
OEA	OEB	QA[0:1]/QA[0:1]	QB[0:1]/QB[0:1]	
0	0	Hi-Z	Hi-Z	
1	1	Enabled	Enabled	

## Table 3C. Frequency Select Table

Inputs	
F_SEL[A, B]	Divider
0	÷5 (default)
1	÷4

#### Table 3B. PLL Bandwidth Function Table

Input	
BW_SEL	PLL Bandwidth
0	~200kHz
Float	~600kHz (default)
1	~2MHz

# **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V <sub>DD</sub>	4.6V
Inputs, V <sub>I</sub>	-0.5V to V <sub>DD</sub> + 0.5V
Outputs, V <sub>O</sub>	-0.5V to V <sub>DDO</sub> + 0.5V
Package Thermal Impedance, $\theta_{JA}$	82.3°C/W (0 mps)
Storage Temperature, T <sub>STG</sub>	-65°C to 150°C

# **DC Electrical Characteristics**

#### Table 4A. Power Supply DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ , $T_A = 0^{\circ}C$ to $70^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
$V_{DD}$	Core Supply Voltage		3.135	3.3	3.465	V
V <sub>DDA</sub>	Analog Supply Voltage		V <sub>DD</sub> – 0.12	3.3	V <sub>DD</sub>	V
V <sub>DDO</sub>	Output Supply Voltage		3.135	3.3	3.465	V
I <sub>DD</sub>	Power Supply Current				45	mA
I <sub>DDA</sub>	Analog Supply Current				12	mA
I <sub>DDO</sub>	Output Supply Current				80	mA

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	um Units
V <sub>IH</sub>	Input High Voltage	OEA, OEB, MR, F_SELA, F_SELB		2		V <sub>DD</sub> + 0.3	V
	BW_SEL		V <sub>DD</sub> – 0.3		V <sub>DD</sub> + 0.3	V	
V <sub>IL</sub> Input Low Voltage	OEA, OEB, MR, F_SELA, F_SELB		-0.3		0.8	V	
	BW_SEL		-0.3		+0.3	V	
V <sub>IM</sub>	Input Mid Voltage	BW_SEL		V <sub>DD</sub> /2 - 0.1		$V_{DD}/2 + 0.1$	V
I <sub>IH</sub>	Input High Current	F_SELA, F_SELB, MR, BW_SEL	$V_{DD} = V_{IN} = 3.465V$			150	μA
		OEA, OEB	$V_{DD} = V_{IN} = 3.465V$			5	μA
IIL Input Low Current	MR, F_SELA, F_SELB,	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-5			μA	
		OEA, OEB, BW_SEL	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-150			μA

## Table 4B. LVCMOS/LVTTL DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ , $T_A = 0^{\circ}C$ to $70^{\circ}C$

## Table 4C. Differential DC Characteristics, $V_{\text{DD}}$ = $V_{\text{DDO}}$ = 3.3V ± 5%, $T_{\text{A}}$ = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
	Input Lligh Current	CLK	$V_{DD} = V_{IN} = 3.465V$			150	μA
IН	Input High Current	CLK	$V_{DD} = V_{IN} = 3.465V$	$ \begin{array}{c} N = 3.465V \\ N = 3.465V \\ = 0V \\ 3.465V, \\ = 0V \\ 3.465V, \\ 150 \\ \end{array} $		5	μA
	Input Low Current	CLK	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-5			μΑ
Ι <sub>ΙĽ</sub>	Input Low Current	CLK	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-150			μA
V <sub>PP</sub>	Peak-to-Peak Voltage	e; NOTE 1		0.15		1.3	V
V <sub>CMR</sub>	Common Mode Input	Voltage; NOTE 1, 2		GND + 0.5		V <sub>DD</sub> – 0.85	V

NOTE 1:  $V_{\rm IL}$  should not be less than -0.3V NOTE 2: Common mode input voltage is defined as  $V_{\rm IH}.$ 

## Table 4D. LVDS DC Characteristics, $V_{\text{DD}}$ = $V_{\text{DDO}}$ = 3.3V ± 5%, $T_{\text{A}}$ = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>OD</sub>	Differential Output Voltage		290	390	490	mV
$\Delta V_{OD}$	V <sub>OD</sub> Magnitude Change				50	mV
V <sub>OS</sub>	Offset Voltage		1.2	1.35	1.5	V
$\Delta V_{OS}$	V <sub>OS</sub> Magnitude Change				50	mV

# **AC Electrical Characteristics**

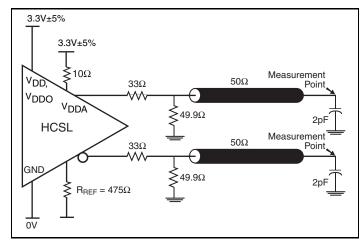
## Table 5. 0.7V Differential AC Characteristics, $V_{\text{DD}} = V_{\text{DDO}} = 3.3V \pm 5\%$ , $T_{\text{A}} = 0^{\circ}$ C to 70°C

Parameter	Symbol		Test Conditions	Minimum	Typical	Maximum	Units
f <sub>MAX</sub>	Output Frequency		Output Frequency	98		160	MHz
<i>t</i> jit(cc)	Cycle-to-Cycle Jitter; NOTE	1				35	ps
<i>t</i> sk(b)	Bank Skew, NOTE 2					30	ps
V <sub>HIGH</sub>	Output Voltage High	QBx/QBx		530		870	mV
V <sub>LOW</sub>	Output Voltage Low	QBx/QBx		-150			mV
V <sub>OVS</sub>	Max. Voltage, Overshoot	QBx/QBx				V <sub>HIGH</sub> + 0.35	V
V <sub>UDS</sub>	Min. Voltage, Undershoot	QBx/QBx		-0.3			V
V <sub>rb</sub>	Ringback Voltage	QBx/QBx				0.2	V
V <sub>CROSS</sub>	Absolute Crossing Voltage	QBx/QBx	@ 0.7V Swing	250		550	mV
$\Delta V_{CROSS}$	Total Variation of V <sub>CROSS</sub> over all edges	QBx/QBx	@ 0.7V Swing			140	mV
t <sub>R</sub> / t <sub>F</sub>	Output Rise/Fall Time	QBx/QBx	measured between 0.175V to 0.525V	175		700	ps
		QAx/QAx	20% to 80%	250		600	ps
$\Delta t_{R} / \Delta t_{F}$	Rise/Fall Time Variation	QBx/QBx				125	ps
t <sub>RFM</sub>	Rise/Fall Matching	QBx/QBx				20	%
odc	Output Duty Cycle			48		52	%

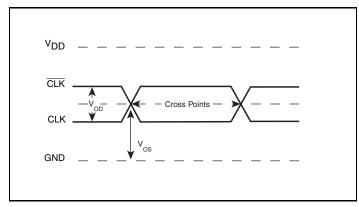
NOTE 1: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 2: Defined as skew within a bank of outputs at the same voltage and with equal load conditions.

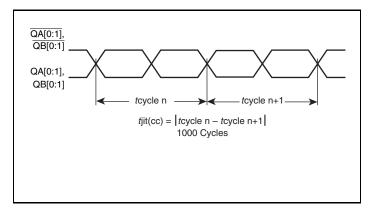
# **Parameter Measurement Information**



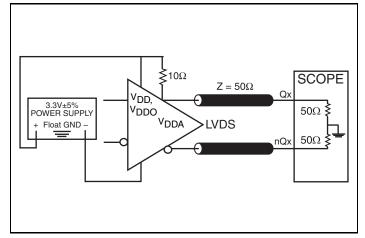
3.3V HCSL Output Load AC Test Circuit



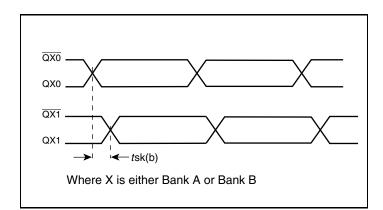
**Differential Input Level** 



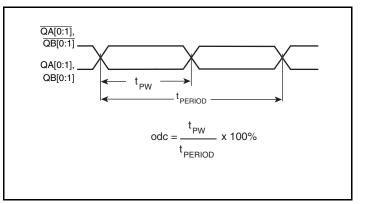
Cycle-to-Cycle Jitter



3.3V LVDS Output Load AC Test Circuit

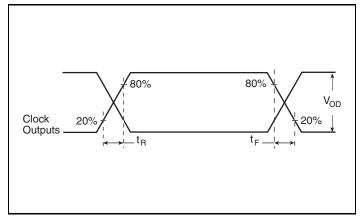


Bank Skew

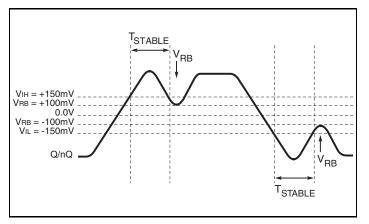


Output Duty Cycle/Pulse Width/Period

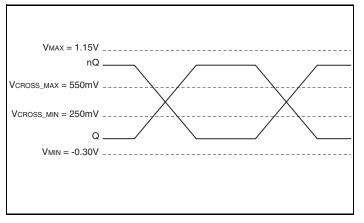
# Parameter Measurement Information, continued



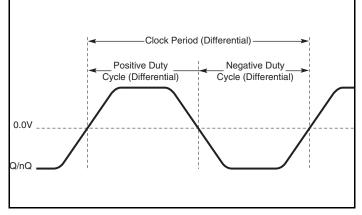




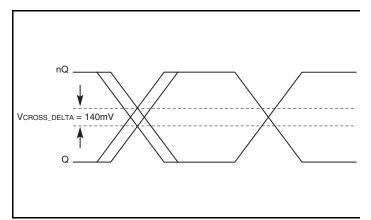
**Differential Measurement Points for Ringback** 



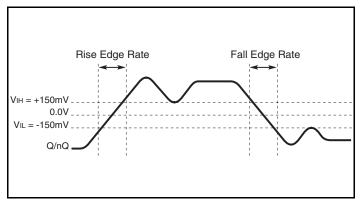
SE Measurement Points for Absolute Cross Point/Swing



**Differential Measurement Points for Duty Cycle/Period** 

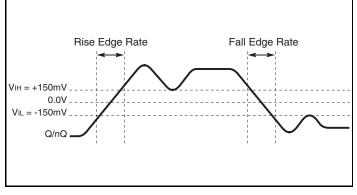


SE Measurement Points for Delta Cross Point

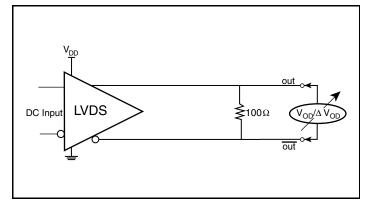


**Differential Measurement Points for Rise/Fall Time** 

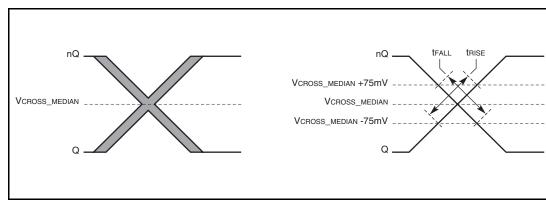
# Parameter Measurement Information, continued



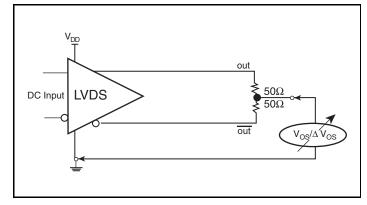
**Differential Measurement Points for Rise/Fall Time** 



#### **Differential Output Voltage Setup**



## SE Measurement Points for Rise/Fall Time Matching



**Offset Voltage Setup** 

# **Application Information**

## **Power Supply Filtering Technique**

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The ICS8741004 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V<sub>DD</sub>, V<sub>DDA</sub> and V<sub>DDO</sub> should be individually connected to the power supply plane through vias, and 0.01µF bypass capacitors should be used for each pin. *Figure 1* illustrates this for a generic V<sub>DD</sub> pin and also shows that V<sub>DDA</sub> requires that an additional 10Ω resistor along with a 10µF bypass capacitor be connected to the V<sub>DDA</sub> pin.

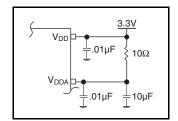


Figure 1. Power Supply Filtering

## Wiring the Differential Input to Accept Single Ended Levels

*Figure 2* shows how the differential input can be wired to accept single ended levels. The reference voltage  $V_REF = V_{DD}/2$  is generated by the bias resistors R1, R2 and C1. This bias circuit should be located as close as possible to the input pin. The ratio of

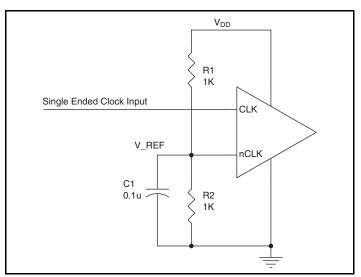
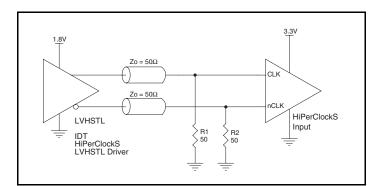


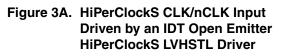
Figure 2. Single-Ended Signal Driving Differential Input

R1 and R2 might need to be adjusted to position the V\_REF in the center of the input voltage swing. For example, if the input clock swing is only 2.5V and  $V_{DD}$  = 3.3V, V\_REF should be 1.25V and R2/R1 = 0.609.

## **Differential Clock Input Interface**

The CLK /nCLK accepts LVDS, LVPECL, LVHSTL, SSTL, HCSL and other differential signals. Both V<sub>SWING</sub> and V<sub>OH</sub> must meet the V<sub>PP</sub> and V<sub>CMR</sub> input requirements. *Figures 3A to 3F* show interface examples for the HiPerClockS CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult with the vendor of the driver





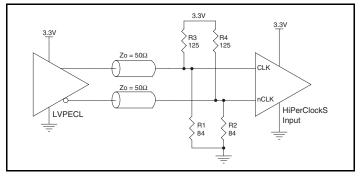


Figure 3C. HiPerClockS CLK/nCLK Input Driven by a 3.3V LVPECL Driver

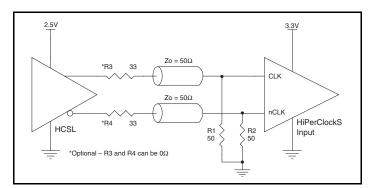


Figure 3E. HiPerClockS CLK/nCLK Input Driven by a 3.3V HCSL Driver

component to confirm the driver termination requirements. For example, in Figure 3A, the input termination applies for IDT HiPerClockS open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

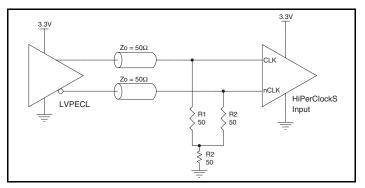


Figure 3B. HiPerClockS CLK/nCLK Input Driven by a 3.3V LVPECL Driver

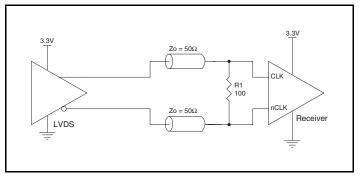
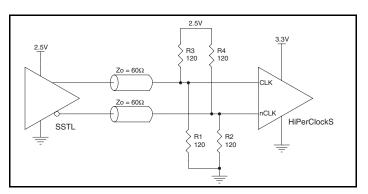
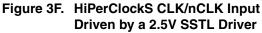


Figure 3D. HiPerClockS CLK/nCLK Input Driven by a 3.3V LVDS Driver





## **Recommendations for Unused Input and Output Pins**

## Inputs:

## **LVCMOS Control Pins**

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

## **Outputs:**

#### **Differential Outputs**

All unused differential outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

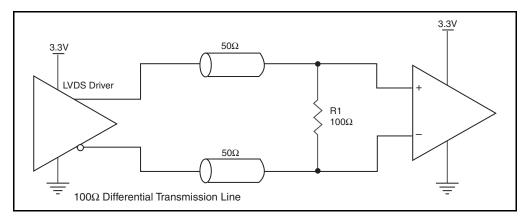
#### **LVDS Outputs**

All unused LVDS output pairs can be either left floating or terminated with  $100\Omega$  across. If they are left floating, we recommend that there is no trace attached.

## **LVDS Driver Termination**

A general LVDS interface is shown in *Figure 4*. In a 100 $\Omega$  differential transmission line environment, LVDS drivers require a matched load termination of 100 $\Omega$  across near the receiver input.

For a multiple LVDS outputs buffer, if only partial outputs are used, it is recommended to terminate the unused outputs.



#### Figure 4. Typical LVDS Driver Termination

## **Recommended Termination**

*Figure 5A* is the recommended termination for applications which require the receiver and driver to be on a separate PCB. All traces should be  $50\Omega$  impedance.

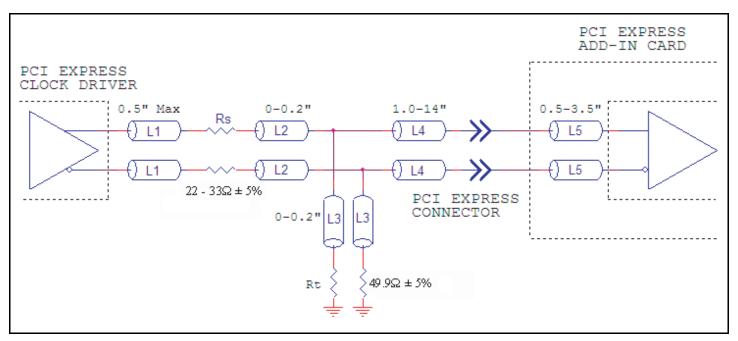


Figure 5A. Recommended Termination

*Figure 5B* is the recommended termination for applications which require a point to point connection and contain the driver and

receiver on the same PCB. All traces should all be  $50\Omega$  impedance.

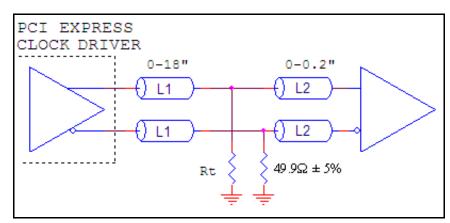


Figure 5B. Recommended Termination

# **Power Considerations**

This section provides information on power dissipation and junction temperature for the ICS8741004. Equations and example calculations are also provided.

#### 1. Power Dissipation.

The total power dissipation for the ICS741004 is the sum of the core power plus the analog power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{DD} = 3.3V + 5\% = 3.465V$ , which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)<sub>MAX</sub> = V<sub>DD\_MAX</sub> \* (I<sub>DD\_MAX</sub> + I<sub>DDA\_MAX</sub>) = 3.465V \* (45mA + 12mA) = 197.5mW
- Power (LVDS\_output)<sub>MAX</sub> = V<sub>DDO MAX</sub> \* I<sub>DDO MAX</sub> = 3.465V \* 80mA = 277.2mW
- Power (HCSL\_output)<sub>MAX</sub> = 44.5mW \* 2 = 89mW

Total Power\_MAX = (3.465V, with all outputs switching) = 197.5mW + 277.2mW + 89mW = 563.7mW

#### 2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS devices is 125°C.

The equation for Tj is as follows: Tj =  $\theta_{JA}$  \* Pd\_total + T<sub>A</sub>

Tj = Junction Temperature

 $\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

Pd\_total = Total Device Power Dissipation (example calculation is in section 1 above)

T<sub>A</sub> = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming no air flow and a multi-layer board, the appropriate value is 82.3°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 70°C with all outputs switching is:

70°C + 0.564W \* 82.3°C/W = 116.4°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (single layer or multi-layer).

#### Table 6. Thermal Resistance $\theta_{\text{JA}}$ for 24 Lead TSSOP, Forced Convection

θ <sub>JA</sub> Vs. Air Flow			
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	82.3°C/W	78.0°C/W	75.9°C/W

#### 3. Calculations and Equations.

The purpose of this section is to calculate power dissipation on the IC per HCSL output pair. HCSL output driver circuit and termination are shown in *Figure 6*.

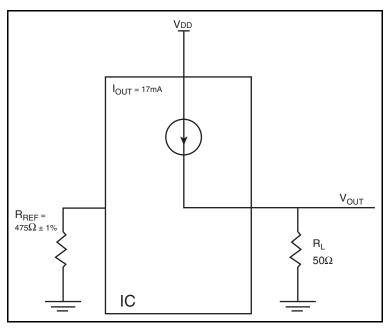


Figure 6. HCSL Driver Circuit and Termination

HCSL is a current steering output which sources a maximum of 17mA of current per output. To calculate worst case on-chip power dissipation, use the following equations which assume a  $50\Omega$  load to ground.

The highest power dissipation occurs when  $V_{\text{DD}-\text{MAX}}.$ 

Power =  $(V_{DD\_MAX} - V_{OUT}) * I_{OUT}$ , since  $V_{OUT} = I_{OUT} * R_L$ =  $(V_{DD\_MAX} - I_{OUT} * R_L) * I_{OUT}$ =  $(3.465V - 17mA * 50\Omega) * 17mA$ 

Total Power Dissipation per output pair = 44.5mW

# **Reliability Information**

## Table 7. $\theta_{\text{JA}}$ vs. Air Flow Table for a 24 Lead TSSOP

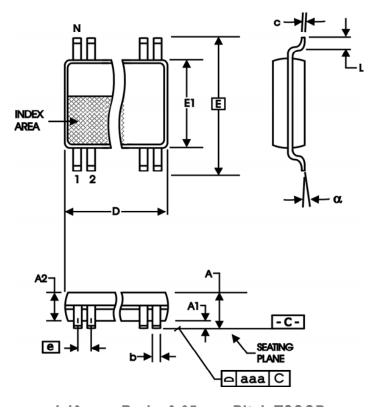
$\theta_{JA}$ vs. Air Flow			
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	82.3°C/W	78.0°C/W	75.9°C/W

## **Transistor Count**

The transistor count for ICS8741004 is: 1318

# Package Outline and Package Dimensions

Package Outline - G Suffix for 24 Lead TSSOP



#### Table 8. Package Dimensions

All Dimensions in Millimeters			
Symbol	Minimum	Maximum	
Ν	24		
Α		1.20	
A1	0.5	0.15	
A2	0.80	1.05	
b	0.19	0.30	
С	0.09	0.20	
D	7.70	7.90	
E	6.40 Basic		
E1	4.30	4.50	
е	0.65 Basic		
L	0.45	0.75	
α	0°	8°	
aaa		0.10	

Reference Document: JEDEC Publication 95, MO-153

# **Ordering Information**

#### **Table 9. Ordering Information**

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
8741004AG	ICS8741004AG	24 Lead TSSOP	Tray	0°C to 70°C
8741004AGT	ICS8741004AG	24 Lead TSSOP	2500 Tape & Reel	0°C to 70°C
8741004AGLF	ICS8741004AGL	"Lead-Free" 24 Lead TSSOP	Tray	0°C to 70°C
8741004AGLFT	ICS8741004AGL	"Lead-Free" 24 Lead TSSOP	2500 Tape & Reel	0°C to 70°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

While the information presented herein has been checked for both accuracy and reliability, Integrated Device Technology (IDT) assumes no responsibility for either its use or for the infringement of any patents or other rights of third parties, which would result from its use. No other circuits, patents, or licenses are implied. This product is intended for use in normal commercial applications. Any other applications, such as those requiring extended temperature ranges, high reliability or other extraordinary environmental requirements are not recommended without additional processing by IDT. IDT reserves the right to change any circuitry or specifications without notice. IDT does not authorize or warrant any IDT product for use in life support devices or critical medical instruments.

# **Revision History Sheet**

Rev	Table	Page	Description of Change	Date
	T4C	5	Differential DC Characteristics Table - added NOTE.	
А	T5 6 AC Characteristics Table - corrected V <sub>HIGH</sub> /V <sub>LOW</sub> units from ps to mV.		AC Characteristics Table - corrected V <sub>HIGH</sub> /V <sub>LOW</sub> units from ps to mV.	10/31/07
~		8 & 9	Added HCSL Parameter Measurement Information.	10/31/07
		11	Updated Differential Clock Input Interface section.	
A	T3C	4 14 & 15	Added F_SEL Function Table. Power Considerations - updated Power Dissipation section to coincide with updates to the Calculations & Equations section on page 15.	5/29/08

## **Contact Information:**



#### Sales

800-345-7015 (inside USA) +408-284-8200 (outside USA) Fax: 408-284-2775 www.IDT.com/go/contactIDT

#### **Technical Support**

netcom@idt.com +480-763-2056

#### **Corporate Headquarters**

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road San Jose, CA 95138 United States 800-345-7015 (inside USA) +408-284-8200 (outside USA)



© 2008 Integrated Device Technology, Inc. All rights reserved. Product specifications subject to change without notice. IDT and the IDT logo are trademarks of Integrated Device Technology, Inc. Accelerated Thinking is a service mark of Integrated Device Technology, Inc. All other brands, product names and marks are or may be trademarks or registered trademarks used to identify products or services of their respective owners. Printed in USA